

Search Notes 	Application/Control No.	Applicant(s)/Patent under Reexamination
	10/688,909	YOSHIDA ET AL.
	Examiner	Art Unit
	Hwei-Siu C. Payer	3724

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
<p>See Interference</p> <p>Search history printout</p>			
<p>2-17-06 Payer</p>			